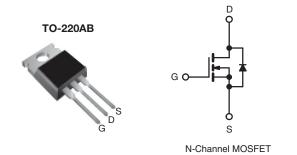


Power MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	60				
R _{DS(on)} (Ω)	V _{GS} = 5.0 V 0.20				
Q _g (Max.) (nC)	8.4				
Q _{gs} (nC)	3.5				
Q _{gd} (nC)	6.0				
Configuration	Single				



FEATURES

- Dynamic dV/dt Rating
- · Logic-Level Gate Drive
- R_{DS(on)} Specified at V_{GS} = 4 V and 5 V
- 175 °C Operating Temperature
- Fast Switching
- · Ease of Paralleling
- Simple Drive Requirements
- Compliant to RoHS Directive 2002/95/EC

DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220AB package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 W. The low thermal resistance and low package cost of the TO-220AB contribute to its wide acceptance throughout the industry.

ORDERING INFORMATION	
Package	TO-220AB
Lead (Pb)-free	IRLZ14PbF
	SiHLZ14-E3
SnPb	IRLZ14
SIIFD	SiHLZ14

PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V_{DS}	60	V	
Gate-Source Voltage	V _{GS}	± 10	1 v			
Continuous Drain Current	V _{GS} at 5.0 V	T _C = 25 °C		10	А	
Continuous Drain Current	V _{GS} at 5.0 V	T _C = 100 °C	ID	7.2		
Pulsed Drain Current ^a	I _{DM}	40	•			
Linear Derating Factor		0.29	W/°C			
Single Pulse Avalanche Energy ^b	E _{AS}	39.5	mJ			
Maximum Power Dissipation T _C = 25 °C			P_{D}	43	W	
Peak Diode Recovery dV/dtc		dV/dt	4.5	V/ns		
Operating Junction and Storage Temperature Rang	T _J , T _{stg}	- 55 to + 175	°C			
Soldering Recommendations (Peak Temperature)	for	10 s		300 ^d		
Mounting Toyour	6-32 or M3 screw			10	lbf ⋅ in	
Mounting Torque				1.1	N⋅m	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. V_{DD} = 25 V, starting T_J = 25 °C, L = 0.79 mH, R_g = 25 Ω , I_{AS} = 10 A (see fig. 12).
- c. $I_{SD} \le 10$ A, $dI/dt \le 90$ A/µs, $V_{DD} \le V_{DS}$, $T_J \le 175$ °C.
- d. 1.6 mm from case.

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply



THERMAL RESISTANCE						
PARAMETER	SYMBOL	MIN.	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R_{thJA}	-	-	62		
Case-to-Sink, Flat, Greased Surface	R _{thCS}	-	0.50	-	°C/W	
Maximum Junction-to-Case (Drain)	R _{thJC}	-	-	3.5		

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT	
Static					•	•		
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		60	-	-	V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Referenc	e to 25 °C, I _D = 1 mA	-	0.070	-	V/°C	
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = 250 \mu A$		1.0	-	2.0	V	
Gate-Source Leakage	I _{GSS}	V _{GS} = ± 10 V		-	-	± 100	nA	
Zaura Onto Valta de Dunius Ocument		V _{DS}	V _{DS} = 60 V, V _{GS} = 0 V		-	25		
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 48 V	, V _{GS} = 0 V, T _J = 150 °C	-	-	250	μA	
Drain Course On State Resistance	D	V _{GS} = 5.0 V	$I_D = 6.0 \text{ A}^b$	-	-	0.20		
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 4.0 V	I _D = 5.0 A ^b	-	-	0.28	Ω	
Forward Transconductance	9 _{fs}	V _{DS} :	= 25 V, I _D = 6.0 A ^b	3.5	-	-	S	
Dynamic								
Input Capacitance	C _{iss}		$V_{GS} = 0 \text{ V}, V_{DS} = 25 \text{ V},$		400	-	pF	
Output Capacitance	C _{oss}	1			170	-		
Reverse Transfer Capacitance	C _{rss}	f = 1	.0 MHz, see fig. 5	-	42	-		
Total Gate Charge	Qg			-	-	8.4	nC	
Gate-Source Charge	Q _{gs}	V _{GS} = 5.0 V	$I_D = 10 \text{ A}, V_{DS} = 48 \text{ V}$ see fig. 6 and 13^b	-	-	3.5		
Gate-Drain Charge	Q _{gd}	1	occ fig. o and fo	-	-	6.0		
Turn-On Delay Time	t _{d(on)}	$V_{DD} = 30 \text{ V}, I_{D} = 10 \text{ A}$ $R_{g} = 12 \Omega, R_{D} = 2.8 \Omega$ see fig. 10^{b}		-	9.3	-	ns	
Rise Time	t _r			-	110	-		
Turn-Off Delay Time	t _{d(off)}			-	17	-		
Fall Time	t _f			-	26	-		
Internal Drain Inductance	L _D	6 mm (0.25") 1	Between lead, 6 mm (0.25") from		4.5	-	-11	
Internal Source Inductance	L _S	package and center of die contact		-	7.5	-	- nH	
Drain-Source Body Diode Characteristic	s				•	•		
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	10	^	
Pulsed Diode Forward Current ^a	I _{SM}			-	-	40	A	
Body Diode Voltage	V _{SD}	T _J = 25 °C, I _S = 10 A, V _{GS} = 0 V ^b		-	-	1.6	V	
Body Diode Reverse Recovery Time	t _{rr}	T. =	25 °C, I _F = 10 A,	-	93	130	ns	
Body Diode Reverse Recovery Charge	Q _{rr}	$J_J = 25 \text{ G, } I_F = 10 \text{ A,}$ $dI/dt = 100 \text{ A/}\mu\text{s}^b$		-	0.34	0.65	μC	
· · ·	t _{on}	+	turn-on is dominated by L_S and L_D)			<u> </u>		

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width \leq 300 µs; duty cycle \leq 2 %.



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

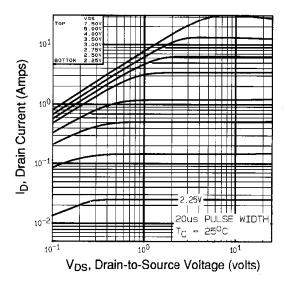


Fig. 1 - Typical Output Characteristics, T_C = 25 °C

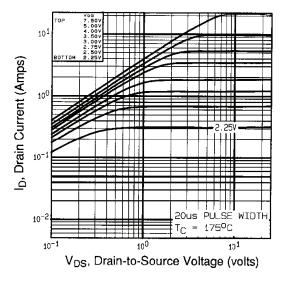


Fig. 2 - Typical Output Characteristics, $T_C = 175$ °C

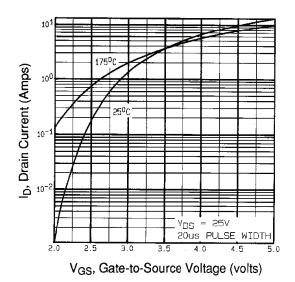


Fig. 3 - Typical Transfer Characteristics

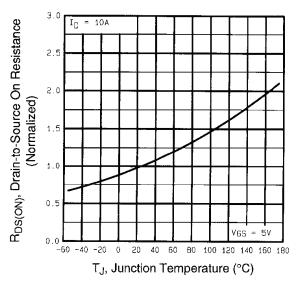


Fig. 4 - Normalized On-Resistance vs. Temperature



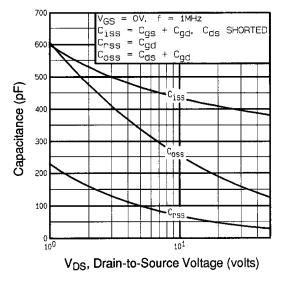


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

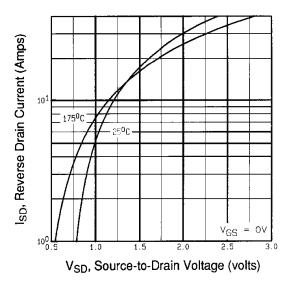


Fig. 7 - Typical Source-Drain Diode Forward Voltage

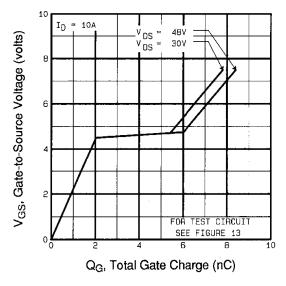


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

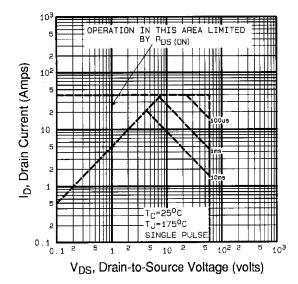


Fig. 8 - Maximum Safe Operating Area





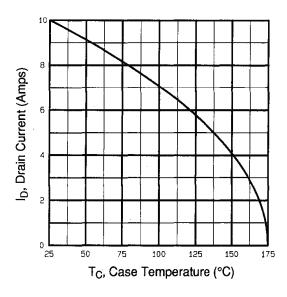


Fig. 9 - Maximum Drain Current vs. Case Temperature

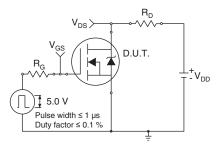


Fig. 10a - Switching Time Test Circuit

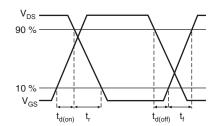


Fig. 10b - Switching Time Waveforms

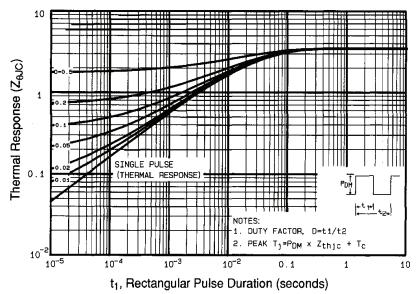


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



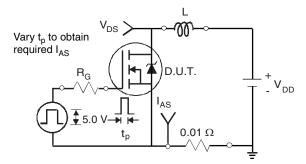


Fig. 12a - Unclamped Inductive Test Circuit

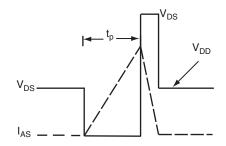


Fig. 12b - Unclamped Inductive Waveforms

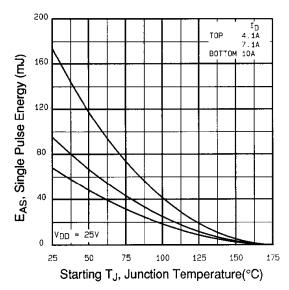


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

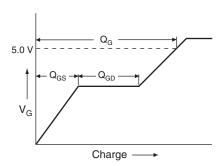


Fig. 13a - Basic Gate Charge Waveform

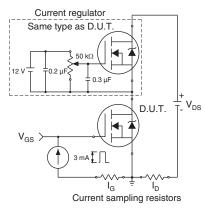
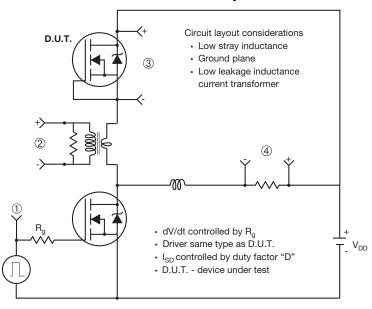


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



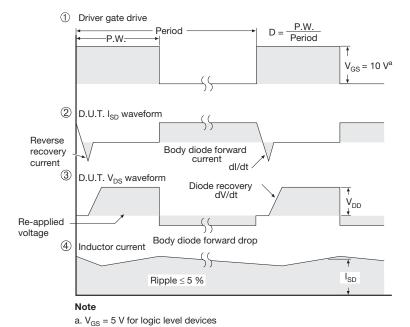


Fig. 14 - For N-Channel

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TO-220-1



DIM.	MILLIM	IETERS	INCHES			
DIM.	MIN.	MAX.	MIN.	MAX.		
Α	4.24	4.65	0.167	0.183		
b	0.69	1.02	0.027	0.040		
b(1)	1.14	1.78	0.045	0.070		
С	0.36	0.61	0.014	0.024		
D	14.33	15.85	0.564	0.624		
Е	9.96	10.52	0.392	0.414		
е	2.41	2.67	0.095	0.105		
e(1)	4.88	5.28	0.192	0.208		
F	1.14	1.40	0.045	0.055		
H(1)	6.10	6.71	0.240	0.264		
J(1)	2.41	2.92	0.095	0.115		
L	13.36	14.40	0.526	0.567		
L(1)	3.33	4.04	0.131	0.159		
ØР	3.53	3.94	0.139	0.155		
Q	2.54	3.00	0.100	0.118		
ECN: X15-0364-Rev. C, 14-Dec-15 DWG: 6031						

Note

 M* = 0.052 inches to 0.064 inches (dimension including protrusion), heatsink hole for HVM



Revison: 14-Dec-15 1 Document Number: 66542



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